

FMF750DC-66A

HIGH POWER SWITCHING USE

INSULATED TYPE

HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Module

MAXIMUM RATINGS

Symbol	Item	Conditions	Ratings	Unit
V_{DSX}	Drain-source voltage	$V_{GS} = -5\text{ V}$, $T_J = -40 \sim 175\text{ }^{\circ}\text{C}$	3300	V
V_{GSS}	Gate-source voltage	$V_{DS} = 0\text{ V}$, $T_J = 25\text{ }^{\circ}\text{C}$	± 20	V
I_D	Drain current	DC, $V_{GS} = +17\text{ V}$, $T_c = 55\text{ }^{\circ}\text{C}$	750	A
I_{DM}		Pulse (Note 1)	1500	A
I_S	Source current (Note 2)	DC, $V_{GS} = -5\text{ V}$	750	A
I_{SM}		Pulse (Note 1)	1500	A
P_{tot}	Maximum power dissipation (Note 3)	$T_c = 25\text{ }^{\circ}\text{C}$, MOSFET part	4650	W
V_{isol}	Isolation voltage	RMS, sinusoidal, $f = 60\text{ Hz}$, $t = 1\text{ min.}$	6000	V
V_e	Partial discharge extinction voltage	RMS, sinusoidal, $f = 60\text{ Hz}$, $Q_{PD} \leq 10\text{ pC}$ $T_J = 25\text{ }^{\circ}\text{C}$	2600	V
T_J	Channel temperature	—	$-40 \sim +175$	$^{\circ}\text{C}$
T_{jop}	Operating channel temperature	—	$-40 \sim +175$	$^{\circ}\text{C}$
T_{slg}	Storage temperature	—	$-40 \sim +175$	$^{\circ}\text{C}$
t_{sc}	Short circuit capability (Maximum pulse width)	$T_J = 175\text{ }^{\circ}\text{C}$, $V_{DD} = 2500\text{ V}$, $V_{GS} = +17/-5\text{ V}$ $R_{G(on)} = 2.0\text{ }\Omega$, $R_{G(off)} = 0.9\text{ }\Omega$, $L_S = 60\text{ nH}$	4	μs

ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
I_{GSS}	Gate leakage current	$V_{GS} = V_{GSS}$, $V_{DS} = 0\text{ V}$, $T_J = 25\text{ }^{\circ}\text{C}$	-2.0	—	2.0	μA
I_{DSX}	Drain-source cut-off current	$V_{DS} = V_{DSX}$, $V_{GS} = -5\text{ V}$	$T_J = 25\text{ }^{\circ}\text{C}$	—	2.5	mA
			$T_J = 150\text{ }^{\circ}\text{C}$	—	—	
			$T_J = 175\text{ }^{\circ}\text{C}$	3.0	—	
$V_{GS(th)}$	Gate-source threshold voltage	$V_{DS} = 10\text{ V}$, $I_C = 75\text{ mA}$	$T_J = 25\text{ }^{\circ}\text{C}$	2.10	—	V
			$T_J = 150\text{ }^{\circ}\text{C}$	1.40	—	
			$T_J = 175\text{ }^{\circ}\text{C}$	1.30	—	
$r_{DS(on)}$	Drain-source resistance	$V_{DS} = V_{DS(on)}$ $V_{GS} = 17\text{ V}$	$T_J = 25\text{ }^{\circ}\text{C}$	2.35	—	m Ω
			$T_J = 150\text{ }^{\circ}\text{C}$	4.55	—	
			$T_J = 175\text{ }^{\circ}\text{C}$	5.20	—	
$V_{DS(on)}$	Drain-source on voltage	$V_{GS} = 17\text{ V}$ $I_D = 750\text{ A}$ (Note 4)	$T_J = 25\text{ }^{\circ}\text{C}$	1.75	—	V
			$T_J = 150\text{ }^{\circ}\text{C}$	3.40	—	
			$T_J = 175\text{ }^{\circ}\text{C}$	3.90	—	
C_{iss}	Input capacitance	$V_{DS} = 10\text{ V}$, $V_{GS} = 0\text{ V}$ $f = 100\text{ kHz}$, $T_J = 25\text{ }^{\circ}\text{C}$	—	209	—	nF
C_{oss}	Output capacitance		—	34	—	nF
C_{rss}	Reverse transfer capacitance		—	0.8	—	nF
Q_G	Total gate charge	$V_{DD} = 1800\text{ V}$, $I_D = 750\text{ A}$, $V_{GS} = +17/-5\text{ V}$	—	6.7	—	μC
$t_{d(on)}$	Turn-on delay time	$V_{DD} = 1800\text{ V}$ $I_D = 750\text{ A}$	$T_J = 150\text{ }^{\circ}\text{C}$	0.80	—	μs
			$T_J = 175\text{ }^{\circ}\text{C}$	0.75	—	
t_r	Rise time	$V_{GS} = +17/-5\text{ V}$ $R_{G(on)} = 2.0\text{ }\Omega$ $L_S = 60\text{ nH}$	$T_J = 150\text{ }^{\circ}\text{C}$	0.51	—	μs
			$T_J = 175\text{ }^{\circ}\text{C}$	0.46	—	
E_{on}	Turn-on switching energy per pulse	Inductive load	$T_J = 150\text{ }^{\circ}\text{C}$	0.60	—	J
			$T_J = 175\text{ }^{\circ}\text{C}$	0.60	—	
$t_{d(off)}$	Turn-off delay time	$V_{DD} = 1800\text{ V}$ $I_D = 750\text{ A}$	$T_J = 150\text{ }^{\circ}\text{C}$	0.95	—	μs
			$T_J = 175\text{ }^{\circ}\text{C}$	1.00	—	
t_f	Turn-off fall time	$V_{GS} = +17/-5\text{ V}$ $R_{G(off)} = 0.9\text{ }\Omega$ $L_S = 60\text{ nH}$	$T_J = 150\text{ }^{\circ}\text{C}$	0.18	—	μs
			$T_J = 175\text{ }^{\circ}\text{C}$	0.18	—	
E_{off}	Turn-off switching energy per pulse	Inductive load	$T_J = 150\text{ }^{\circ}\text{C}$	0.25	—	J
			$T_J = 175\text{ }^{\circ}\text{C}$	0.25	—	

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ELECTRICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
V _{SD}	Source-drain voltage (Note 2)	V _{GS} = 0 V I _S = 750 A (Note 4)	T _J = 25 °C	—	2.50	V
			T _J = 150 °C	—	3.35	
			T _J = 175 °C	—	3.50	
V _{SD}	Source-drain voltage (Note 2)	V _{GS} = +17 V I _S = 750 A (Note 4)	T _J = 25 °C	—	1.20	V
			T _J = 150 °C	—	2.10	
			T _J = 175 °C	—	2.40	
I _{FSM}	Surge forward current (Note 2)	V _{SD} = 0 V, t _p = 10 ms, T _J = 150 °C start	—	—	—	kA
I ² t	Surge current load integral (Note 2)		—	—	—	kA ² s
Q _C	Total capacitive charge (Note 2)	V _{DD} = 1800 V, I _D = 750 A di _S /dt ≈ 1700 A/μs L _S = 60 nH	T _J = 150 °C	—	30	μC
			T _J = 175 °C	—	40	
E _{off_diode}	Diode turn-off energy per pulse (Note 2)		T _J = 150 °C	—	0.02	J
			T _J = 175 °C	—	0.03	

THERMAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
R _{th(j-c)Q}	Thermal resistance	Junction to Case, MOSFET part 1/2 module	—	—	32.0	K/kW
R _{th(j-c)D}		Junction to Case, FWDi part 1/2 module	—	—	54.5	K/kW
R _{th(c-s)}	Contact thermal resistance	Case to heat sink, 1/2 module λ _{grease} = 1 W/m·K, D _(c-s) = 100 μm	—	22.5	—	K/kW

MECHANICAL CHARACTERISTICS

Symbol	Item	Conditions	Limits			Unit
			Min	Typ	Max	
M _t	Mounting torque	Main terminals screw M8 (Note 5)	7.0	—	14.0	N·m
M _s		Mounting screw M6	3.0	—	6.0	N·m
M _t		Auxiliary terminals screw M3	0.4	—	0.6	N·m
m	Mass	—	—	0.80	—	kg
CTI	Comparative tracking index	—	600	—	—	—
d _a	Clearance	Between terminals and baseplate	19.2	—	—	mm
d _s	Creepage distance	Between terminals and baseplate	32.0	—	—	mm
L _{P-P-N}	Parasitic stray inductance	Between terminal 1,2 and terminal 6,7	—	14.0	—	nH
L _{p s-ss}	Internal inductance	Between Auxiliary terminals (terminal 10-11)	—	3.0	—	nH
		Between Auxiliary terminals and DC- (terminal 13-6,7)	—	5.0	—	nH
R _{DD'+SS'}	Internal lead resistance	Between DC+ and DC- (terminal 1,2-6,7)	—	0.46	—	mΩ
		Between DC+ and AC (terminal 1,2-3,4,5)	—	0.22	—	
		Between AC and DC- (terminal 3,4,5-6,7)	—	0.33	—	

Note 1. Pulse width and repetition rate should be such that junction temperature (T_J) does not exceed T_{J,max} rating.

Note 2. The symbols represent characteristics of the anti-parallel, source to drain free-wheel diode (FWDi).

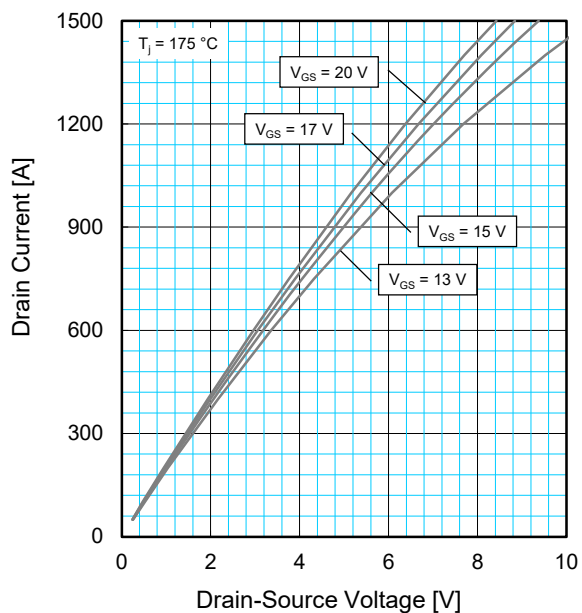
Note 3. Junction temperature (T_J) should not exceed T_{J,max} rating.

Note 4. Pulse width and repetition rate should be such as to cause negligible temperature rise.

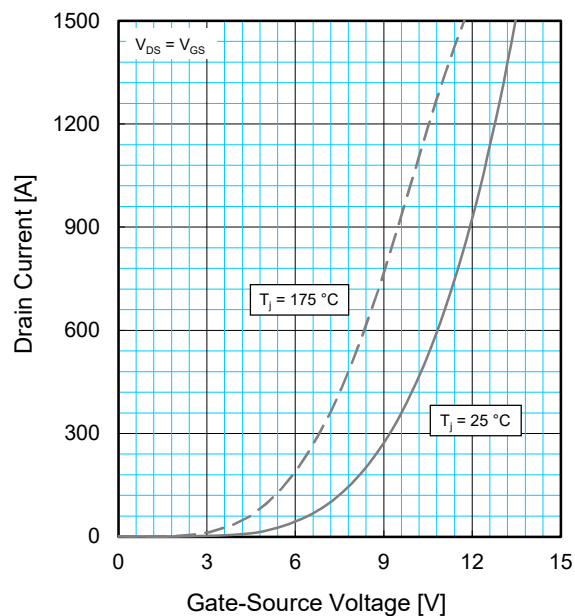
Note 5. This is the case when installing the product on the bus bar.

PERFORMANCE CURVES

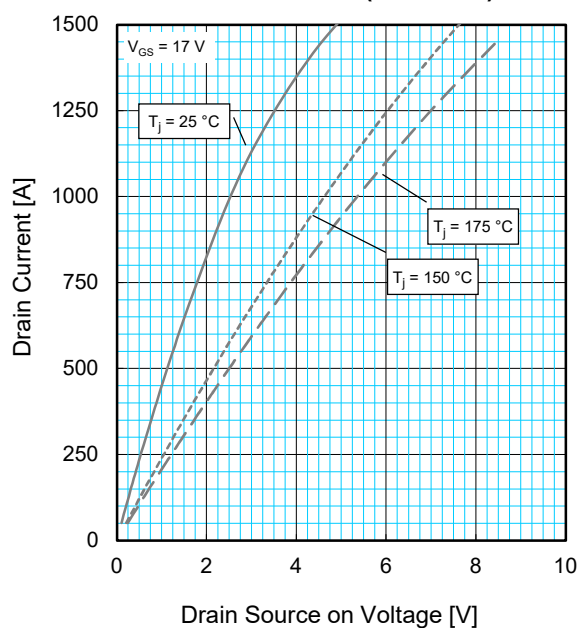
**OUTPUT CHARACTERISTICS
(TYPICAL)**



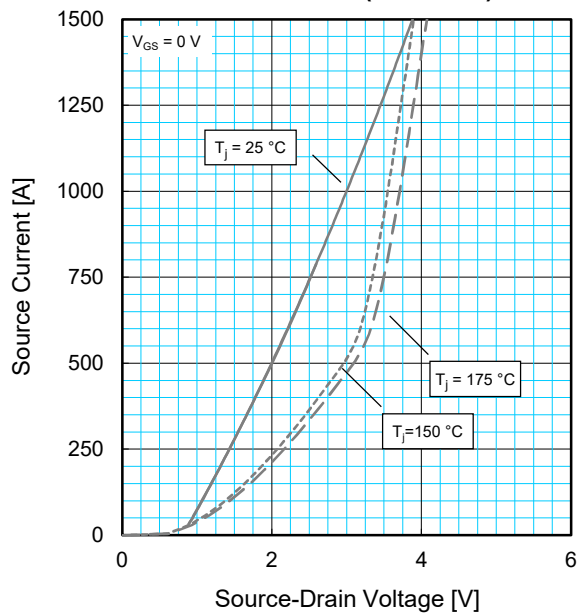
**TRANSFER CHARACTERISTICS
(TYPICAL)**



**DRAIN-SOURCE ON VOLTAGE
CHARACTERISTICS (TYPICAL)**



**FREE-WHEEL DIODE FORWARD
CHARACTERISTICS (TYPICAL)**



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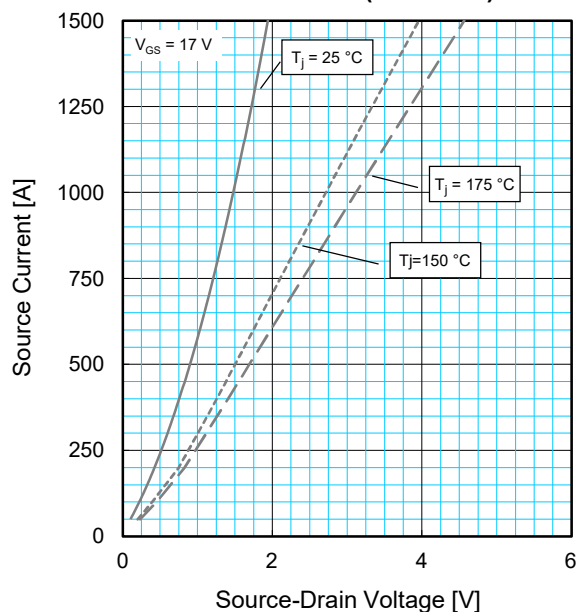
HIGH POWER SWITCHING USE

INSULATED TYPE

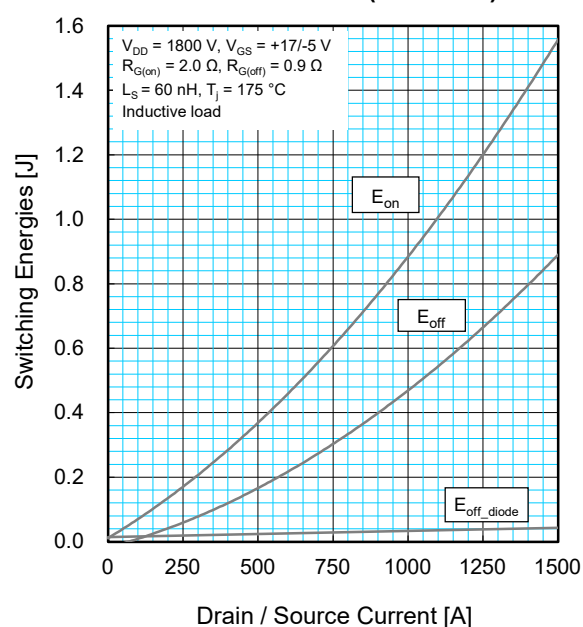
HVMOSFET (High Voltage Metal Oxide Semiconductor Field Effect Transistor) Module

PERFORMANCE CURVES

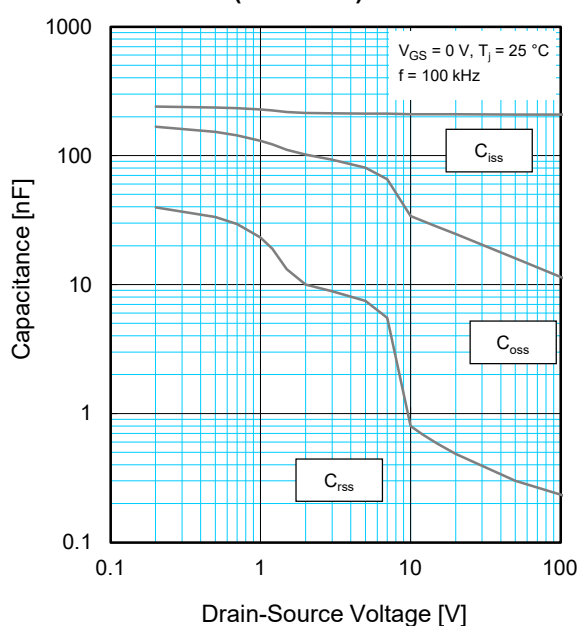
FREE-WHEEL DIODE FORWARD CHARACTERISTICS (TYPICAL)



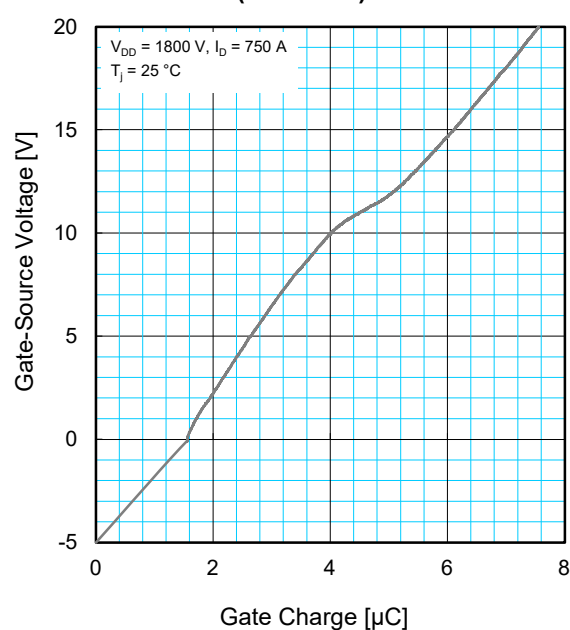
HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)



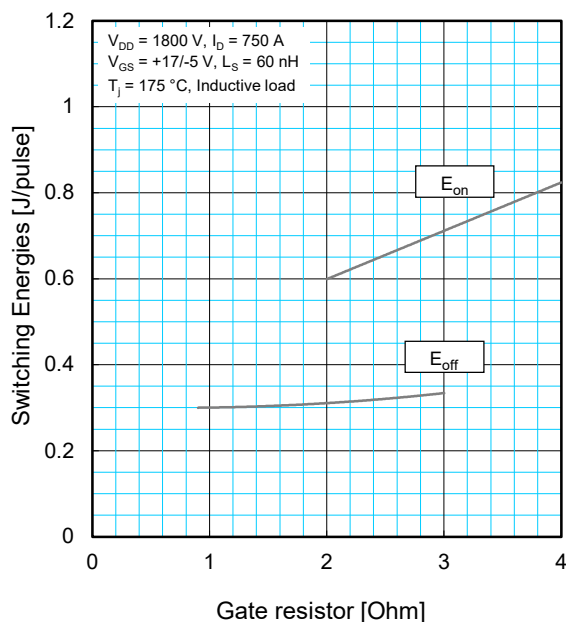
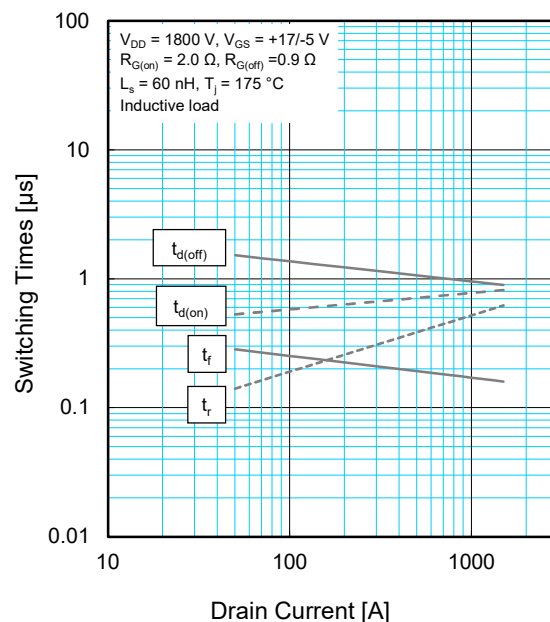
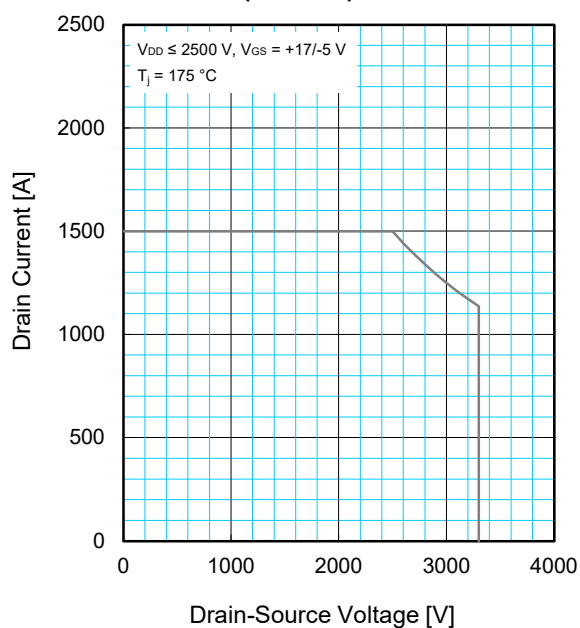
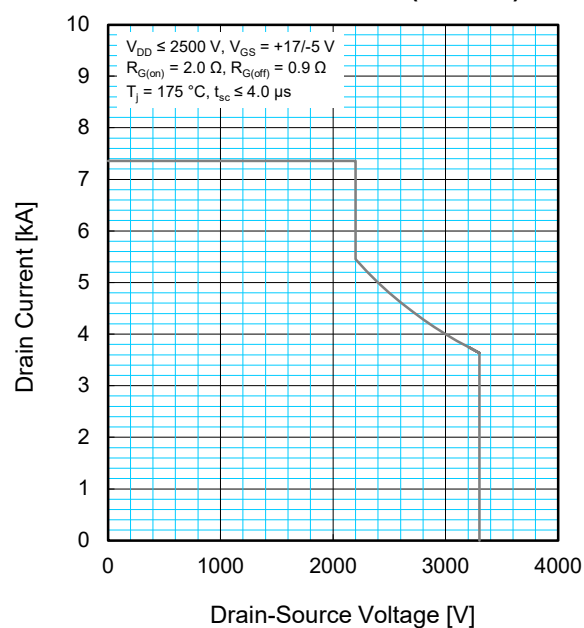
CAPACITANCE CHARACTERISTICS (TYPICAL)



GATE CHARGE CHARACTERISTICS (TYPICAL)



PERFORMANCE CURVES

HALF-BRIDGE SWITCHING ENERGY CHARACTERISTICS (TYPICAL)**HALF-BRIDGE SWITCHING TIME CHARACTERISTICS (TYPICAL)****REVERSE BIAS SAFE OPERATING AREA (RBSOA)****SHORT CIRCUIT SAFE OPERATING AREA (SCSOA)**

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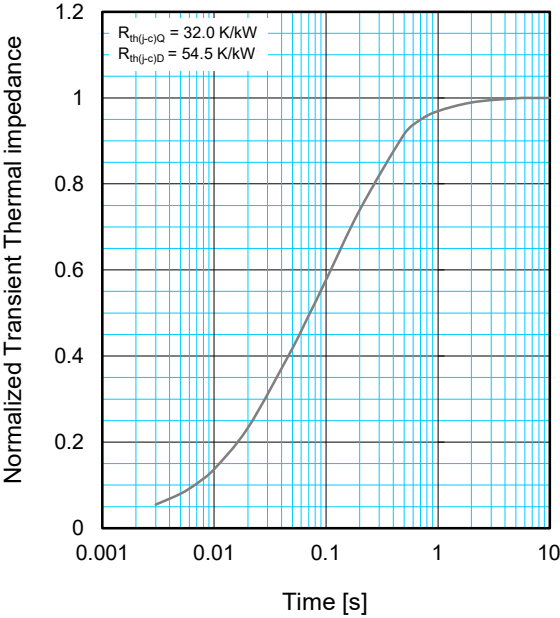
HIGH POWER SWITCHING USE

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PERFORMANCE CURVES

TRANSIENT THERMAL IMPEDANCE
CHARACTERISTICS



$$Z_{th(j-c)}(t) = \sum_{i=1}^n R_i \left\{ 1 - \exp\left(-\frac{t}{\tau_i}\right) \right\}$$

	1	2	3	4
$R_i / R_{th(j-c)}$	0.0145	0.3107	0.5977	0.0772
τ_i [s]	0.0001	0.0291	0.1797	1.0024

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